

Experimental observation of oscillations of electronic ultrasound absorption in a semiconductor placed in an alternating field

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Oscillations and reversal of the sign of the coefficient of electronic absorption of ultrasound of frequency 0.5 and 0.7 GHz was observed experimentally in n -InSb crystals placed in an alternating electric field of frequency 1.8 GHz. The experiments were performed at a temperature 77 K in magnetic fields up to 6 kOe.

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Much attention has been paid recently to the study of the interaction of ultrasonic wave (USW) with electrons in semiconductors placed in an alternating electric field.^[1–5] The possible existence of “giant” oscillations of the electronic absorption coefficient α as a function of the amplitude of the alternating electric field was theoretically predicted in^[1,2].

In the present paper we present the results of an experiment that confirms the existence of such oscillations. We have investigated the dependence of the electronic absorption coefficient of piezoactive shear USW propagating along the [110] direction in n -InSb crystals placed in liquid nitrogen. The experiments were formed at USW frequencies 500 and 700 MHz. Crystals with electron density $n \approx 1.0 \times 10^{14} \text{ cm}^{-3}$ and mobility $\mu_0 \approx 600000 \text{ cm}^2/\text{V sec}$ were cut in the form of rectangular bars measuring $1 \times 0.7 \times 7 \text{ mm}$. An alternating voltage of frequency $\omega/2\pi = 1.8 \text{ GHz}$ was applied to the sample in the USW propagation direction through annular indium Ohmic contacts. The distance d between the contacts was 5 mm. The microwave voltage on the sample was measured with a stroboscopic oscilloscope. To excite and receive the USW we used epitaxial CdS transducers. The experiments were performed in a magnetic field H perpendicular to the USW propagation direction. The magnetic field was sufficient to satisfy the condition $q_s R_c \ll 1$ (q_s is the USW wave vector and R_c is the cyclotron radius); according to^[5], this makes the conclusion of the hydrodynamic theory^[1–4] applicable. Registration of the USW, as well as the relative measurements of the absorption coefficient, were carried out by an “echo” method. The experimental setup was similar to that described in^[6].

The measurement procedure consisted in the following: when the magnetic field was turned on (at $U_- = 0$), the level of the recorded “echo” signals decreased abruptly—the electronic absorption increased (α is negligibly small at $H = 0$). Turning on the microwave voltage during the time of propagation of the USW through the crystal led to a further increase of its amplitude raised the level of the echo pulses and caused them to oscillate. The electronic absorption coefficient and its field-induced changes, per unit crystal length, were then calculated from the measurement results.

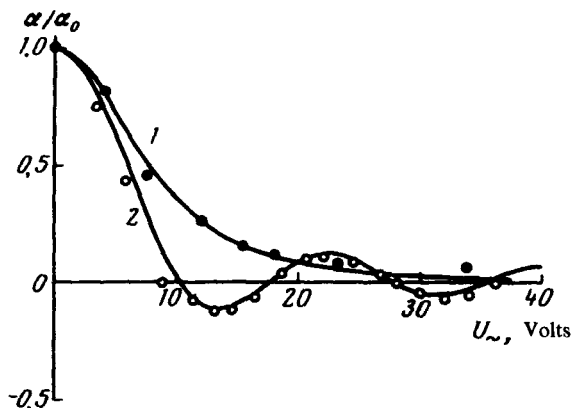


FIG. 1.

Figure 1 shows plots of the electronic absorption coefficient against the amplitude of the microwave voltage on the sample. The experimental data are shown by the points, and the solid curves are theoretical^[2,3] and calculated with a computer from the formula

$$\alpha = K^2 q_s^2 \sum_{m=-\infty}^{\infty} I_m^2(x) \frac{(\omega_s + m\omega) \tau_M}{(1 + q_s^2 r_D^2)^2 + (\omega_s + m\omega)^2 \tau_M^2}, \text{ cm}^{-1} \quad (1)$$

where K^2 is the square of the coefficient of the electromechanical coupling, ω_s is the cyclic frequency of the USW, $\tau_M \approx \tau_M^0 (\mu_0 H / c)^2$,^[5] where τ_M^0 is the Maxwellian relaxation time and c is the speed of light, r_D is the Debye radius, and $I_m(x)$ is an m th order Bessel function of argument $x = (V_{d \text{ UHF}} / V_s)(\omega_s / \omega)$, where $V_{d \text{ UHF}}$ is the drift velocity in the microwave field. In the determination of the latter we took into account the effect of the magnetoresistance $V_{d \text{ UHF}} \approx \mu_0 (U_- / d) [R(0) / R(H)]$, where $R(0)$ and $R(H)$ are the sample resistances with the magnetic field turned off and on, respectively. α_0 is the value of α_e in the absence of a microwave field ($U_- = 0$). The curves shown on Fig. 1 correspond to two different values of the magnetic field, $H = 2$ kOe and $H = 6$ kOe. The experimental data obtained for these fields are marked by dark and light circles, respectively. As seen from Fig. 1, they agree well with the theory. At $H = 2$ kOe the absorption coefficient decreases smoothly with increasing U_- , while at $H = 6$ kOe the decrease of the absorption coefficient is accompanied by clearly pronounced oscillations. According to^[1,2], the oscillations should be noticeable at $\omega \tau_M \gtrsim 1$. At $H = 6$ kOe we have $\omega \tau_M = 2, 1, \dots$ and the oscillations are in fact observed. We note, as seen from Fig. 1, that in the presence of a microwave we have not only oscillations of the absorption coefficient but also a reversal of its sign. The possibility of the reversal of the sign of α in a microwave field was indicated in^[2]. The experimental observation and investigation of the oscillations were carried out at the ultrasound frequency 700 MHz. The obtained data also agree with the theory.

We have thus obtained an experimental confirmation of the existence of "giant"

oscillations of the electronic absorption coefficient and of the reversal of its sign in a semiconductor placed in alternating electric field.

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¹E.M. Épshtein, Pis'ma Zh. Eksp. Teor. Fiz. 7, 433 (1968) [JETP Lett. 7, 340 (1968)]; Fiz. Tverd. Tela (Leningrad) 10, 2945 (1968) [Sov. Phys. Solid State 10, 2325 (1969)].

²V.M. Levin and L.A. Chernozatonskiĭ, Zh. Eksp. Teor. Fiz. 59, 142 (1970) [Sov. Phys. JETP 32, 79 (1971)].

³R.H. Pantell and T. Soo Hoo, J. Appl. Phys. 41, 442 (1970).

⁴A.S. Bugaev, Yu.V. Gulyaev, V.V. Denisenko, and Zh. E. Smbatyan, Fiz. Tekh. Poluprovodn. 12, No. 1 (1978) [Sov. Phys. Semicond. 12, No. 1 (1978)].

⁵V.M. Levin and L.A. Chernozatonskiĭ, Fiz. Tekh. Poluprovodn. 7, 1124 (1973) [Sov. Phys. Semicond. 7, 760 (1974)].

⁶S.N. Ivanov and G.D. Mansfel'd, Fiz. Tekh. Poluprovodn. 4, 40 (1970) [Sov. Phys. Semicond. 4, 30 (1970)].